## 国際会議 2015 年度

● [9] 2015/10/24@Hangzhou in China

The 16th International Manufacturing Conference in China (IMCC2015)

Plasma-assisted polishing: Novel damage-free atomically flat finishing technique for wide gap semiconductor materials

OK. Yamamura

• [8] 2015/10/06@Jeju in Korea

The 18th International Symposium on Advances in Abrasive Technology (ISAAT2015)

Study on removal mechanism of sapphire in plasma assisted polishing

OC. Kageyama, K. Monna, H. Deng, K. Endo, K. Yamamura

• [7] 2015/09/29@ILL- Grenoble in France

4th International Workshop on Neutron Delivery Systems

**Development of a Neutron Microscope using Wolter Supermirrors** 

OK. Soyama, H. Hayashida, D. Yamazaki, R. Maruyama, Y. Goto, K. Yamamura

● [6] 2015/08/25@Cape Town in South Africa

65th CIRP General Assembly

Plasma-assisted polishing of gallium nitride to obtain a pit-free and atomically flat surface

OH. Deng, K. Endo, K. Yamamura

• [5] 2015/08/18@Harbin in China

The 6th International Conference of Asian Society for Precision Engineering and Nanotechnology (ASPEN2015)

Planarization and Smoothing of CVD Grown Diamond Wafer by Atmospheric Pressure Plasma Based Process

OH. Dojo, T. Tabata, K. Endo, H. Yamada, A. Chyayahara, Y. Mokuno, K. Yamamura

• [4] 2015/08/18@Harbin in China

The 6th International Conference of Asian Society for Precision Engineering and Nanotechnology (ASPEN2015)

Improvement of Form Accuracy in NC-PCVM by Compensation of Surface Temperature Change OS. Sakaiya, K. Endo, K. Yamamura

[3] 2015/08/18@Harbin in China

The 6th International Conference of Asian Society for Precision Engineering and Nanotechnology (ASPEN2015)

Demonstration of Electro-Chemical Mechanical Polishing of Singlecrystal SiC

OK. Yamamura, K. Hosoya, Y. Imanishi, H. Deng, K. Endo

[2] 2015/06/04@Leuven in Belgium
 15th International Conference of the European Society for Precision Engineering and Nanotechnology
 Polishing characteristics of CVD-SiC in plasma-assisted polishing
 OH. Deng, K. Endo, K. Yamamura

■ [1] 2015/06/04@Leuven in Belgium

15th International Conference of the European Society for Precision Engineering and Nanotechnology

Flattening of single crystal SiC by combination of anodic oxidation and soft abrasive polishing

○H. Deng, K. Hosoya, Y. Imanishi, K. Endo, K. Yamamura